







CSD18511KCS

SLPS548A - JULY 2017 - REVISED MARCH 2024

CSD18511KCS 40V N-Channel NexFET™ Power MOSFET

1 Features

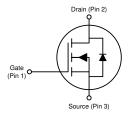
- Low Q_a and Q_{ad}
- Low R_{DS(ON)}
- Low-thermal resistance
- Avalanche rated
- Lead-free terminal plating
- RoHS compliant
- Halogen free
- TO-220 plastic package

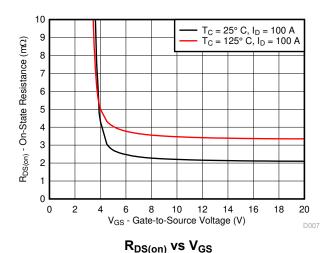
2 Applications

- Secondary side synchronous rectifier
- Motor control

3 Description

This 40V, 2.1mΩ, TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.





Product Summary

T _A = 25°	С	TYPICAL VA	UNIT	
V _{DS}	Drain-to-Source Voltage 40			
Qg	Gate Charge Total (10V)	63.9	nC	
Q _{gd}	Gate Charge Gate-to-Drain	9.7	nC	
D	Drain-to-Source On-Resistance	V _{GS} = 4.5V 3.2		mΩ
R _{DS(on)}	Dialii-to-Source Off-Resistance	V _{GS} = 10V 2.1		11122
V _{GS(th)}	Threshold Voltage			V

Device Information(1)

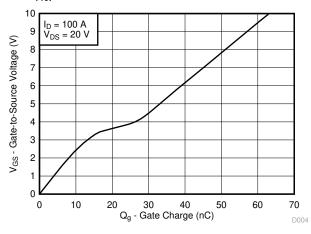
DEVICE	DEVICE MEDIA		PACKAGE	SHIP	
CSD18511KCS	Tube	50	TO-220 Plastic Package	Tube	

For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

	2 2							
T _A = 2	5°C	VALUE	UNIT					
V_{DS}	Drain-to-Source Voltage	40	V					
V _{GS}	Gate-to-Source Voltage	±20	V					
	Continuous Drain Current (Package Limited)	110						
I _D	Continuous Drain Current (Silicon Limited), T _C = 25°C	194	Α					
	Continuous Drain Current (Silicon Limited), T _C = 100°C	137						
I _{DM}	Pulsed Drain Current ⁽¹⁾	400	Α					
P _D	Power Dissipation	188	W					
T _J , T _{stg}	Operating Junction, Storage Temperature	-55 to 175	°C					
E _{AS}	Avalanche Energy, Single Pulse I_D = 56A, L = 0.1mH, R_G = 25 Ω	156	mJ					

(1) Max R_{θJC} = 0.8°C/W, pulse duration ≤ 100μs, duty cycle ≤ 1%.



Gate Charge



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4 Specifications

4.1 Electrical Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS				
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0V, I _D = 250μA	40		V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0V, V _{DS} = 32V		1	μΑ
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0V, V _{GS} = 20V		100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5 1.8	2.4	V
В	Drain to course on registence	V _{GS} = 4.5V, I _D = 100A	3.2	4.2	m0
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 10V, I _D = 100A	2.1	2.6	mΩ
g _{fs}	Transconductance	V _{DS} = 4V, I _D = 100A	249		S
DYNAM	IC CHARACTERISTICS			<u> </u>	
C _{iss}	Input capacitance		4570	5940	pF
C _{oss}	Output capacitance	$V_{GS} = 0V, V_{DS} = 20V, f = 1MHz$	454	591	pF
C _{rss}	Reverse transfer capacitance		235	306	pF
R _G	Series gate resistance		0.9	1.8	Ω
Qg	Gate charge total (4.5V)		31		nC
Qg	Gate charge total (10V)		64		nC
Q _{gd}	Gate charge gate-to-drain	V _{DS} = 20V, I _D = 100A	9.7		nC
Q _{gs}	Gate charge gate-to-source		17.9		nC
Q _{g(th)}	Gate charge at V _{th}		7.4		nC
Q _{oss}	Output charge	V _{DS} = 20V, V _{GS} = 0V	20.7		nC
t _{d(on)}	Turnon delay time		8		ns
t _r	Rise time	V _{DS} = 20V, V _{GS} = 10V,	6		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 100A$, $R_G = 0\Omega$	17		ns
t _f	Fall time		3		ns
DIODE (CHARACTERISTICS		•	<u> </u>	
V _{SD}	Diode forward voltage	I _{SD} = 100A, V _{GS} = 0V	0.9	1.0	V
Q _{rr}	Reverse recovery charge	V _{DS} = 20V, I _F = 100A,	62		nC
t _{rr}	Reverse recovery time	di/dt = 300A/µs	31		ns

4.2 Thermal Information

T_A = 25°C (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.8	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	°C/W

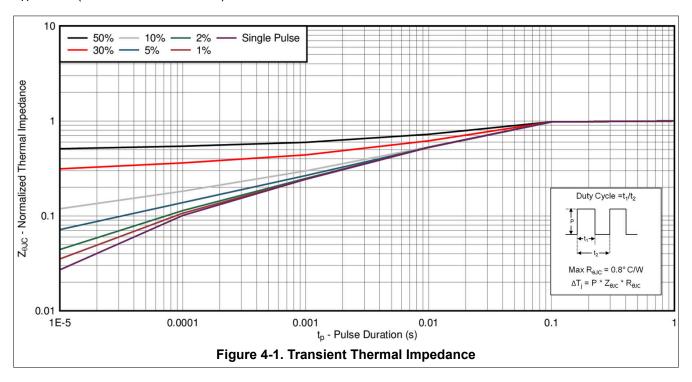
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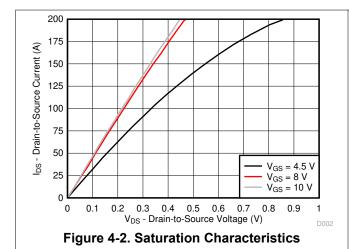
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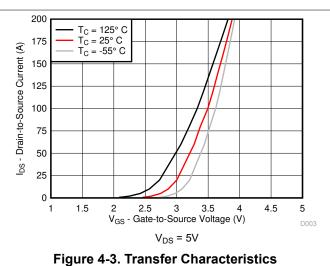


4.3 Typical MOSFET Characteristics

 $T_A = 25$ °C (unless otherwise stated)

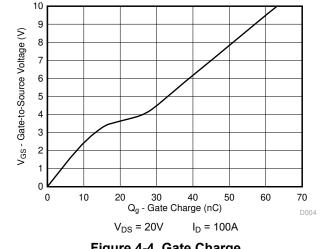






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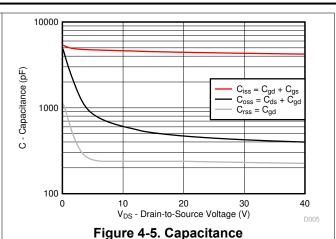
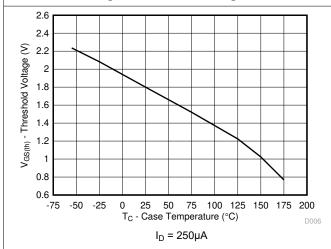


Figure 4-4. Gate Charge



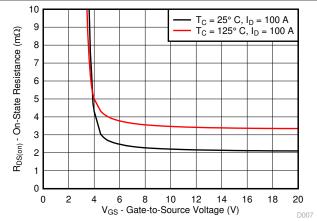


Figure 4-6. Threshold Voltage vs Temperature

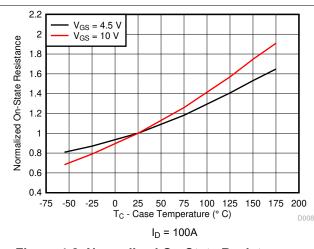


Figure 4-7. On-State Resistance vs Gate-to-Source Voltage

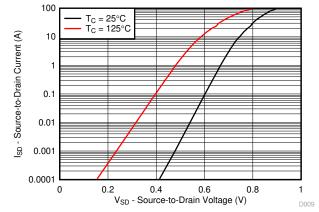
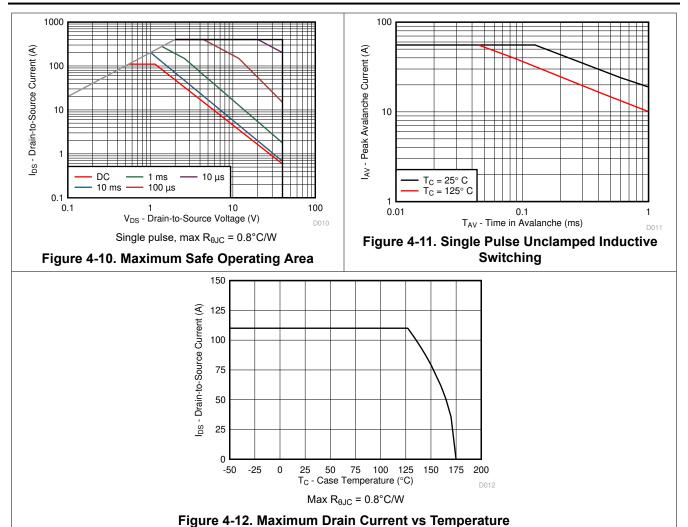


Figure 4-8. Normalized On-State Resistance vs **Temperature**

Figure 4-9. Typical Diode Forward Voltage







5 Device and Documentation Support

5.1 Third-Party Products Disclaimer

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (July 2017) to Revision A (March 2024)

Page



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CSD18511KCS	ACTIVE	TO-220	KCS	3	50	RoHS-Exempt & Green	SN	N / A for Pkg Type	-55 to 175	CSD18511KCS	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

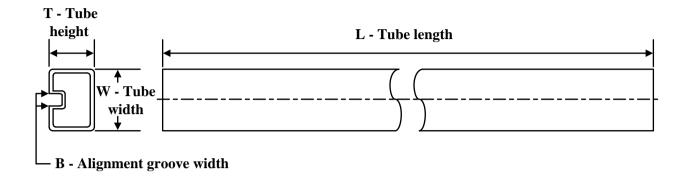
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PACKAGE MATERIALS INFORMATION

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TUBE

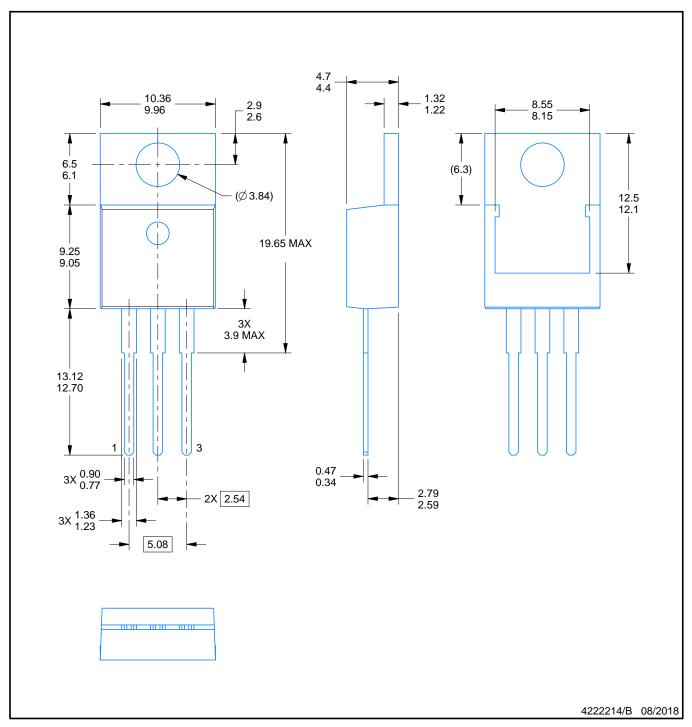


*All dimensions are nominal

ĺ	Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
-	CSD18511KCS	KCS	TO-220	3	50	532	34.1	700	9.6



TO-220



NOTES:

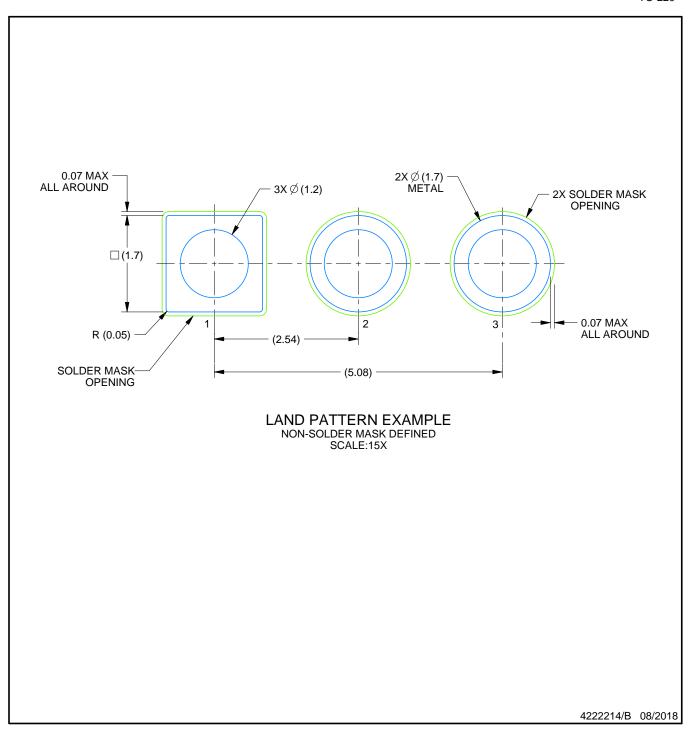
- 1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Reference JEDEC registration TO-220.



TO-220



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